

## EAST Search History

Ref #	Hits	Search Query	DBs	Default Operator	Plurals	Time Stamp
L1	4	shimizu-takashi\$.in. and @pd>"20061020"	US-PGPUB; USPAT; EPO	OR	ON	2006/12/26 11:12
L2	0	sakamoto-hironori\$.in. and @pd>"20061020"	US-PGPUB; USPAT; EPO	OR	ON	2006/12/26 11:13
L3	139	nec adj electronics\$.as. and @pd>"20061020"	US-PGPUB; USPAT; EPO	OR	ON	2006/12/26 11:13
L4	27	l3 and diffusion	US-PGPUB; USPAT; EPO	OR	ON	2006/12/26 11:13
L5	107	703/2,14.ccls. and @pd>"20061020"	US-PGPUB; USPAT; EPO	OR	ON	2006/12/26 11:24
L6	156	(diffusion near length).clm.	US-PGPUB	OR	ON	2006/12/26 11:25
L7	37	l6 and correct\$3	US-PGPUB	OR	ON	2006/12/26 11:26
L8	7	l6 and correct\$3.clm.	US-PGPUB	OR	ON	2006/12/26 11:27
L9	20	(transistor near model).clm.	US-PGPUB	OR	ON	2006/12/26 11:27
L10	4	l9 and correct\$3.clm.	US-PGPUB	OR	ON	2006/12/26 11:31
L11	2606	(source and isolation and drain).clm.	US-PGPUB	OR	ON	2006/12/26 11:31
L12	1635	l11 and transistor.clm.	US-PGPUB	OR	ON	2006/12/26 11:31
L13	0	l12 and "parameter.clm"	US-PGPUB	OR	ON	2006/12/26 11:31
L14	0	l12 and "parameter.clm."	US-PGPUB	OR	ON	2006/12/26 11:31
L15	10	l12 and parameter.clm.	US-PGPUB	OR	ON	2006/12/26 11:33
L16	13	(diffusion near size).clm.	US-PGPUB	OR	ON	2006/12/26 11:33
S5	134	shimizu-takashi\$.in.	US-PGPUB; USPAT; EPO	OR	ON	2006/12/26 11:12
S8	30	sakamoto-hironori\$.in.	US-PGPUB; USPAT; EPO	OR	ON	2006/12/26 11:13
S10	2723	703/2,14.ccls.	US-PGPUB; USPAT; EPO	OR	ON	2006/12/26 11:15

## EAST Search History

S10 6	17	(US-20020095273-\$ or US-20020083406-\$ or US-20010042873-\$).did. or (US-5687355-\$ or US-5825673-\$ or US-6555872-\$ or US-5648920-\$ or US-5481485-\$ or US-6909976-\$ or US-5993050-\$ or US-6304836-\$ or US-6269277-\$ or US-6851097-\$ or US-6618837-\$ or US-6314390-\$ or US-6649429-\$ or US-6642560-\$). did.	US-PGPUB; USPAT	OR	ON	2006/12/06 14:12
S10 7	4	S106 and (diffusion near length)	US-PGPUB; USPAT	OR	ON	2006/12/06 14:19
S10 8	3	S106 and (isolation near region)	US-PGPUB; USPAT	OR	ON	2006/12/06 14:19
S10 9	5921	(diffusion near size) or (diffusion near length)	US-PGPUB; USPAT; EPO	OR	ON	2006/12/07 09:05
S11 0	1406	S109 and isolation	US-PGPUB; USPAT; EPO	OR	ON	2006/12/07 08:52
S11 1	645	S110 and (source and drain)	US-PGPUB; USPAT; EPO	OR	ON	2006/12/07 08:53
S11 2	112	S111 and simulat\$3	US-PGPUB; USPAT; EPO	OR	ON	2006/12/07 08:53
S11 3	32	S112 and mobility	US-PGPUB; USPAT; EPO	OR	ON	2006/12/07 08:53
S11 4	32	S113 and ((threshold adj voltage) or "vth")	US-PGPUB; USPAT; EPO	OR	ON	2006/12/07 09:05
S11 5	615	(diffusion near size)	US-PGPUB; USPAT; EPO	OR	ON	2006/12/07 09:05
S11 6	119	S115 and isolation	US-PGPUB; USPAT; EPO	OR	ON	2006/12/07 09:05
S11 7	20	S116 and simulat\$3	US-PGPUB; USPAT; EPO	OR	ON	2006/12/07 09:08
S11 8	32	(diffusion near size)	JPO	OR	ON	2006/12/07 09:09
S11 9	0	S118 and simulat\$3	JPO	OR	ON	2006/12/07 09:08
S12 0	0	S118 and isolation	JPO	OR	ON	2006/12/07 09:09